

Notice of References Cited	Application/Control No. 10/712,777		Applicant(s)/Patent Under Reexamination SCHMIDT ET AL.	
	Examiner Ajay Vasudeva		Art Unit 3617	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
X	A	US-5,277,117	01-1994	Bender et al.	102/402
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

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X	O	JP 52143691 A	11-1977	Japan	ARIKAWA et al.	B63B 35/40
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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